

Notice of References Cited	Application/Control No. 10/617,114		Applicant(s)/Patent Under Reexamination WENG ET AL.	
	Examiner Brook Kebede		Art Unit 2823	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,824,374	10-1998	Bradley et al.	427/555
X	B	US-5,981,970	11-1999	Dimitrakopoulos et al.	257/40
X	C	US-6,080,606	06-2000	Gleskova et al.	438/151
X	D	US-6,087,196	07-2000	Sturm et al.	438/29
X	E	US-2003/0047729	03-2003	Hirai et al.	257/40
X	F	US-2003/0059984	03-2003	Sirringhaus et al.	438/141
X	G	US-6,602,790	08-2003	Kian et al.	438/690
X	H	US-6,603,139	08-2003	Tessler et al.	257/40
X	I	US-2003/0226996	12-2003	Aramaki et al.	252/62.30Q
X	J	US-2003/0211649	11-2003	Hirai et al.	438/48
X	K	US-2003/0160235	08-2003	Hirai, Katsura	257/40
X	L	US-6,697,694	02-2004	Mogensen, Steven Allen	700/119
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Q					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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